# IAP6 Rec'd PCT/PTO 30 MAR 2006 P ST



PATENT thibaut2.d01

#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of :

Jacques THIBAUT, ET AL. :

Application No. 10/550,779 :

Filing Date: September 27, 2005 :

For a Patent for an :

AUTOMATIC MEASURING DEVICE

FOR MEASURING THE DIMENSIONS

OF A TOOL FOR A MACHINE TOOL : March 28, 2006

#### INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

This paper is being filed to advise the U.S. Patent Office of information which may be considered "material to patentability" in examining this patent application, in accordance with the provisions of 37 C.F.R. §1.56.

This application is derived from International Application No. PCT/FR2004/000506, and was filed pursuant to 35 U.S.C. §371. The following documents are noted for being cited in the Search Report issued during the international stage of the PCT Application:

## U.S. Patent

4,016,784 (Brown) - Issued: April 12, 1977

## Foreign Documents

JP 60 127958 (Sumitomo Spec. Metals) -

- Published: July 8, 1985\*

JP 09 155693 (Hitachi Seiki Co. Ltd.) -

- Published: June 17, 1997\*\*

# Other Documents

Patent Abstracts of Japan, vol. 009, No. 286 (M-429) -

- Published: November 13, 1985 \*(citing JP 60 127958)

Patent Abstracts of Japan, vol. 1997, No. 10 -

- Published: October 31, 1997 \*\*(citing JP 09 155693)

Copies of the above-listed documents should already have been received by the U.S. Patent Office, and a PTO-1449 form has been enclosed with this Information Disclosure Statement to facilitate the Examiner's acknowledgement of the above-listed documents.

The U.S. Patent Office is further advised of an earlier search which was performed relative to French Patent Application No. 03/03917, the priority of which is claimed in connection with the present application. A copy of the issued Search Report,

No. FA 632325, is enclosed with this Information Disclosure Statement. The documents cited in the French Search Report duplicate the documents cited in the PCT Search Report.

The U.S. Patent Office is further advised that the present application was co-filed with an application derived from an International Application, No. PCT/FR2004/000507, filed March 4, 2004. The U.S. application derived from International Application No. PCT/FR2004/000507 has since been assigned the U.S. Patent Application No. 10/550,780. A Search Report issued for International Application No. PCT/FR2004/000507, and a Search Report (No. FA 634782) issued for French Patent Application No. 03/03918, the priority of which was claimed in connection with International Application No. PCT/FR2004/000507, cite the same documents, including:

# U.S. Patent

5,716,045 (Taylor) - Issued: February 10, 1998

#### Foreign Documents

EP 1 157 778 (Precision Automation, Inc.) -

- Published: November 28, 2001

EP 0 646 438 (GFM Gesellschaft...) -

- Published: April 5, 1995

Copies of the above-listed Search Reports and

"foreign documents" have been enclosed with this Information
Disclosure Statement for consideration in this matter. A concise
explanation of the relevance of the non-English language document
is available with reference to the Search Report which cited
the non-English language document. A copy of the U.S. patent
document has not been enclosed with this Information Disclosure
Statement in view of the waiver of such requirements for
International Applications which entered their U.S. national
stage after June 30, 2003 (OG Notices; 05 August 2003).

French Patent Application No. 03/03918 was published under the No. 2,852,874 on October 1, 2004, and a copy of FR 2,852,874 is enclosed with this Information Disclosure Statement.

Due consideration of the foregoing documents is respectfully requested under 37 C.F.R. §1.56(a)(2). It is further respectfully requested that the Examiner acknowledge consideration of the above-listed documents by initialing the PTO-1449 form (1) which is enclosed with this Information Disclosure Statement and which lists the foregoing documents, and by providing applicants with an initialed copy of the enclosed PTO-1449 form to confirm consideration of the listed documents.

I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to "Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450" on March 28, 2006.

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Sary M. Cohen, Esq.

Respectfully submitted,

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Reg. No. 28,834

Attorney for Applicants

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**EXAMINER** 

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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not conformance and not considered. Include copy of this form with next communication to applicant.